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No. 1 Workshop, M-10, Middle section, Science & Technology Park, Nanshan

District, Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

Email: ee.shenzhen@sgs.com

SAR Evaluation Report

Application No.: SZEM1306003389RF

Applicant: Shenzhen Netcom Electronics CO., Ltd **Manufacturer:** Shenzhen Netcom Electronics CO., Ltd

Product Name: airdisk

Model No.(EUT): NW71 256GB

Add Model No.: NW71 32GB, NW71 64GB, NW71 128GB

FCC ID: 2AANHNW71

Standards: 47 CFR Part 1.1307(2012)

47 CFR Part 2.1093 (2012)

KDB447498D01 General RF Exposure Guidance v05

Date of Receipt: 2013-07-04

Date of Test: 2013-07-24 to 2013-08-26

Date of Issue: 2013-09-10

Test Result : PASS*

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Jack Zhang EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government. All test results in this report can be traceable to National or International Standards.

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3 General Information

3.1 Client Information

Applicant:	Shenzhen Netcom Electronics CO., Ltd
Address of Applicant:	Shenzhen: 8/F, 1 Building, Finance Base, No.8, Kefa Road, High-Tech Park, Shenzhen, China
Manufacturer:	Shenzhen Netcom Electronics CO., Ltd
Address of Manufacturer:	Shenzhen: 8/F, 1 Building, Finance Base, No.8, Kefa Road, High-Tech Park, Shenzhen, China

3.2 General Description of EUT

Product Name:	airdisk
Model No.:	NW71 32GB, NW71 64GB, NW71 128GB, NW71 256GB
Operation Frequency:	IEEE 802.11b/g/n(HT20): 2412MHz to 2462MHz
	IEEE 802.11n(HT40): 2422MHz to 2452MHz
Modulation Type:	IEEE for 802.11b: DSSS(CCK,DQPSK,DBPSK) IEEE for 802.11g : OFDM(64QAM, 16QAM, QPSK, BPSK)
	IEEE for 802.11n(HT20 and HT40) : OFDM (64QAM, 16QAM,
	QPSK,BPSK)
Number of Channel:	IEEE 802.11b/g, IEEE 802.11n HT20: 11 Channels
	IEEE 802.11n HT40: 7 Channels
Channel Separation:	5MHz
Sample Type:	Portable production
Antenna Type	Integral antenna
Antenna Gain	2.0dBi
AC Adapter:	Model : JD-050100
	Input: 100V-240V 50/60Hz 0.5A
	Output: 5V == 1000mA
Test Voltage:	120V 60Hz

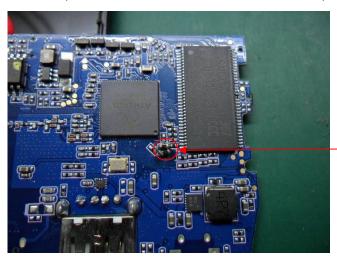


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Remark:

The EUT passed the all tests after modification. See picture below:



Change these two resistance to chip bead Model No.:ACMS160808A101

3.3 Test Location

All tests were performed at:

 ${\tt SGS-CSTC\ Standards\ Technical\ Services\ Co.,\ Ltd.\ Shenzhen\ Branch\ E\&E\ Lab}$

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.



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3.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

VCCI

The 3m Semi-anechoic chamber, Full-anechoic Chamber and Shielded Room (7.5m x 4.0m x 3.0m) of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-2197, G-416, T-1153 and C-2383 respectively.

FCC – Registration No.: 556682

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

Industry Canada (IC)

Two 3m Semi-anechoic chambers of SGS-CSTC Standards Technical Services Co., Ltd. have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1 & 4620C-2.

3.5 Deviation from Standards

None.

3.6 Abnormalities from Standard Conditions

None.

3.7 Other Information Requested by the Customer

None.

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4 SAR Evaluation

4.1 RF Exposure Compliance Requirement

4.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v05

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

4.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation¹⁷

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

4.1.3 EUT RF Exposure

The max. power of channel, including tune-up tolerance is 8dBm in highest channel(2.462GHz); 8dBm logarithmic terms convert to numeric result is nearly6.3095mW

According to the formula. calculate the EIRP test result:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] \cdot [$\sqrt{f(GHz)}$]

General RF Exposure = $(6.3095 \text{mW} / 5 \text{ mm}) \times \sqrt{2.462 \text{GHz}} = 2.0 \text{ }$

SAR requirement:

S= 3.0 ②;

(1) < (2).

So the SAR report is not required.

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